

PCTEST

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HEARING AID COMPATIBILITY

Applicant Name:

Samsung Electronics Co., Ltd. 129, Samsung-ro, Maetan dong, Yeongtong-gu, Suwon-si Gyeonggi-do 16677, Korea Date of Testing:

5/3/2021

Test Site/Location:

PCTEST, Columbia, MD, USA

Test Report Serial No.:

1M2112280170-04.A3L

Date of Issue: 2/15/2022

FCC ID: A3LSMF926U

APPLICANT: SAMSUNG ELECTRONICS CO., LTD.

Scope of Test: Audio Band Magnetic Testing (T-Coil)

Application Type: Class II Permissive Change

FCC Rule Part(s): CFR §20.19(b)
HAC Standard: ANSI C63.19-2011

285076 D01 HAC Guidance v05

285076 D02 T-Coil testing for CMRS IP v03

DUT Type: Portable Handset Model: SM-F926U Additional Model(s): SM-F926U1

Test Device Serial No.: Pre-Production Sample [S/N: 2037M]

Class II Permissive Change(s): See FCC Change Document

C63.19-2011 HAC Category: T3 (SIGNAL TO NOISE CATEGORY, NR n48 ONLY)

This report and category pertain only to NR n48 supported by this wireless portable device. The overall category rating of the device is determined by the lowest rating obtained over all air interfaces supported by the device. This wireless portable device has been shown to be hearing-aid compatible under the above rated category, specified in ANSI/IEEE Std. C63.19-2011 and has been tested in accordance with the specified measurement procedures. Test results reported herein relate only to the item(s) tested. Hearing-Aid Compatibility is based on the assumption that all production units will be designed electrically identical to the device tested in this report. North American Bands only.

I attest to the accuracy of data. All measurements reported herein were performed by me or were made under my supervision and are correct to the best of my knowledge and belief. I assume full responsibility for the completeness of these measurements and vouch for the qualifications of all persons taking them.







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1. INTRODUCTION

On July 10, 2003, the Federal Communications Commission (FCC) adopted new rules requiring wireless manufacturers and service providers to provide digital wireless phones that are compatible with hearing aids. The FCC has modified the exemption for wireless phones under the Hearing Aid Compatibility Act of 1998 (HAC Act) in WT Docket 01-309 RM-8658¹ to extend the benefits of wireless telecommunications to individuals with hearing disabilities. These benefits encompass business, social and emergency communications, which increase the value of the wireless network for everyone. An estimated more than 10% of the population in the United States show signs of hearing impairment and of that fraction, almost 80% use hearing aids. Approximately 500 million people worldwide and 30 million people in the United States suffer from hearing loss.

Compatibility Tests Involved:

The standard calls for wireless communications devices to be measured for:

- RF Electric-field emissions
- T-coil mode, magnetic-signal strength in the audio band
- T-coil mode, magnetic-signal frequency response through the audio band
- T-coil mode, magnetic-signal and noise articulation index

The hearing aid must be measured for:

- RF immunity in microphone mode
- RF immunity in T-coil mode

In the following tests and results, this report includes the evaluation for a wireless communications device.



Figure 1-1 Hearing Aid in-vitu

¹ FCC Rule & Order, WT Docket 01-309 RM-8658

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DUT DESCRIPTION 2.



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Applicant: Samsung Electronics Co., Ltd.

129, Samsung-ro, Maetan dong,

Yeongtong-gu, Suwon-si Gyeonggi-do 16677, Korea

Model: SM-F926U SM-F926U1 Additional Model(s):

Serial Number: 2037M HW Version: REV1.0

SW Version: F926USQU1AUGFb Antenna: Internal Antenna DUT Type: Portable Handset

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Table 2-1 A3LSMF926U HAC Air Interfaces

			731	SWF9200 HAC All Interna	l		
Air-Interface	Band (MHz)	Type Transport	HAC Tested	Simultaneous But Not Tested	Name of Voice Service	Audio Codec Evaluated	
CDMA	835 1900	vo	No ³	Yes: WIFI or BT	CMRS Voice	EVRC	
CDIVIA	EvDO	VD	No ³	Yes: WIFI or BT	Google Duo	OPUS	
	850	VD	NO	res. Wiri Oi Bi	Google Duo	OF03	
GSM	1900	vo	No ³	Yes: WIFI or BT	CMRS Voice	EFR	
GSIVI	GPRS/EDGE	VD	No ³	Yes: WIFI or BT	Google Duo	OPUS	
	850						
LINATE	1700	VD	No ³	Yes: WIFI or BT	CMRS Voice	NB AMR, WB AMR	
UMTS	1900						
	HSPA	VD	No ³	Yes: WIFI or BT	Google Duo	OPUS	
	680 (B71)						
	700 (B12)						
	780 (B13)						
	790 (B14)						
	850 (B5)						
()	850 (B26)		3			Volte: NB AMR, WB AMR, EVS	
LTE (FDD)	1700 (B4)	VD	No ³	Yes: NR, WIFI or BT	VoLTE, Google Duo	Google Duo: OPUS	
	1700 (B66)						
	1900 (B2) 1900 (B25)						
		1					
	2300 (B30)	1					
	2500 (B7)						
	2600 (B38)						
LTE (TDD)	2600 (B41)	VD	No ³	Yes: NR, WIFI or BT	VoLTE, Google Duo	Volte: NB AMR, WB AMR, EVS	
	3600 (B48)					Google Duo: OPUS	
	680 (n71)						
	700 (n12)						
	850 (n5)	1					
NR (FDD)	1700 (n66)	VD	No ³	Yes: LTE, WIFI or BT	Google Duo ¹	OPUS	
	1900 (n2)						
	1900 (n25)						
	2300 (n30)	1					
	2600 (n41)		,				
	3500 (n77, DoD)	1	No ³				
	3600 (n48)	1	Yes ²				
NR (TDD)	3700 (n77)	VD	1.03	Yes: LTE, WIFI or BT	Google Duo ¹	OPUS	
	28000 (n261)	1	No ³				
	39000 (n260)	1					
	2450						
	5200 (U-NII 1)						
	5300 (U-NII 2A)						
	5500 (U-NII 2C)	1					
WIFI	5800 (U-NII 3)	VD	No ³	Yes: CDMA, GSM, UMTS, LTE, or NR	VoWIFI, Google Duo	VoWIFI: NB AMR, WB AMR, EVS	
	6175 (U-NII 5)	- ***			,	Google Duo: OPUS	
	6475 (U-NII 6)						
	6700 (U-NII 7)	1					
	7000 (U-NII 8)	1					
ВТ	2450	DT	No	Yes: CDMA, GSM, UMTS, LTE, or NR	N/A	N/A	
Type Transport			Notes:				
VO = Voice Onl							
	ta - Not intended for			luated using an interim procedure outlined in Sec		oort (T-coil report S/N:	
VD - CIVING ATIC	D = CMRS and/or IP Voice over Data Transport 3. This report pertains only to NR n48. For full data, please refer to the original certification Test report (T-coil report S/N:				ore (1-con report 3/14.		

3. This report pertains only to NR n48. For full data, please refer to the original certification Test report (T-coil report S/N: 1M2104020031-24-R1.A3L).

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3. ANSI C63.19-2011 PERFORMANCE CATEGORIES

I. MAGNETIC COUPLING

Axial and Radial Field Intensity

All orientations of the magnetic field, in the axial and radial position along the measurement plane shall be \geq -18 dB(A/m) at 1 kHz in a 1/3 octave band filter per §8.3.1.

Frequency Response

The frequency response of the axial component of the magnetic field shall follow the response curve specified in EIA RS-504-1983, over the frequency range 300 Hz – 3000 Hz per §8.3.2.

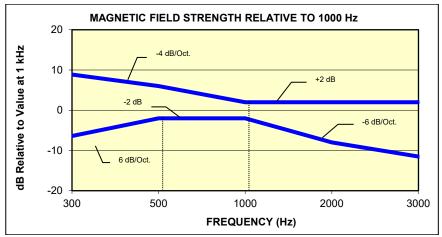


Figure 3-1
Magnetic field frequency response for Wireless Devices with an axial field ≤-15 dB(A/m) at 1 kHz

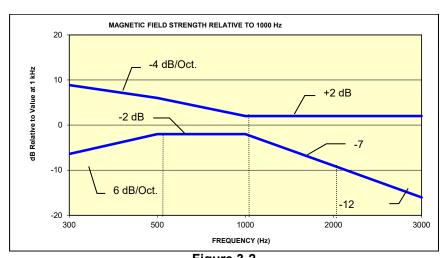


Figure 3-2
Magnetic Field frequency response for wireless devices with an axial field that exceeds
-15 dB(A/m) at 1 kHz

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Signal Quality

The table below provides the signal quality requirement for the intended audio magnetic signal from a wireless device. Only the RF immunity of the hearing aid is measured in T-coil mode. It is assumed that a hearing aid can have no immunity to an interference signal in the audio band, which is the intended reception band for this mode. The only criterion that can be measured is the RF immunity in T-coil mode. This is measured using the same procedure as the audio coupling mode at the same levels.

The signal quality of the axial and radial components of the magnetic field was used to determine the T-coil mode category.

Category	Telephone RF Parameters			
Calegory	Wireless Device Signal Quality [(Signal + Noise)-to-noise ratio in dB]			
T1	0 to 10 dB			
T2	10 to 20 dB			
Т3	20 to 30 dB			
T4	> 30 dB			
Table 3-1 Magnetic Coupling Parameters				

Note: The FCC limit for SNNR is 20dB and the test data margins will indicate a margin from the FCC limit for compliance.

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4. METHOD OF MEASUREMENT

I. Test Setup

The equipment was connected as shown in an acoustic/RF hemi-anechoic chamber:

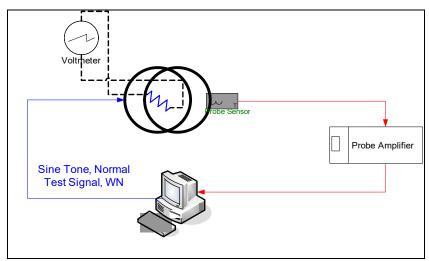


Figure 4-1
Validation Setup with Helmholtz Coil

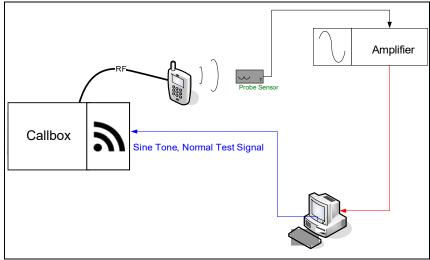


Figure 4-2 T-Coil Test Setup

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II. Scanning Mechanism

Manufacturer: TEM

Accuracy: ± 0.83 cm/meter

Minimum Step Size: 0.1 mm

Maximum speed 6.1 cm/sec

Line Voltage: 115 VAC

Line Frequency: 60 Hz

Material Composite: Delrin (Acetal)

Data Control: Parallel Port

Dynamic Range (X-Y-Z): 45 x 31.75 x 47 cm

Dimensions: 36" x 25" x 38" Operating Area: 36" x 49" x 55"

Reflections: < -20 dB (in anechoic chamber)

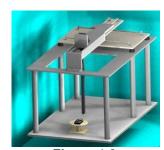


Figure 4-3 RF Near-Field Scanner

III. 3GPP2 Normal Test Signal (Speech)

Manufacturer: 3GPP2 (TIA 1042 §3.3.1)

Modified-IRS weighted, multi-talker speech signal, 4 Male and 4

Stimulus Type: Female speakers (alternating)

Single Sample Duration: 51.62 seconds

Activity Level: 77.4%

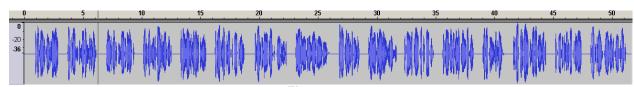
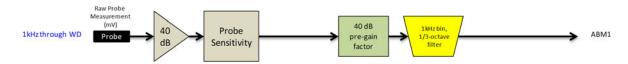


Figure 4-4
Temporal Characteristic of Normal Test Signal

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ABM2 Measurement Block Diagram:



Figure 4-5 Magnetic Measurement Processing Steps

IV. Test Procedure

- 1. Ambient Noise Check per C63.19 §7.3.1
 - Ambient interference was monitored using a Real-Time Analyzer between 100-10,000 Hz with 1/3 octave filtering.
 - b. "A-weighting" and Half-Band Integration was applied to the measurements.
 - c. Since this measurement was measured in the same method as ABM2 measurements, this level was verified to be more than 10 dB below the lowest measurement signal (which is the highest ABM2 measurement for a T4 WD). Therefore the maximum noise level for a T4 WD with an ABM1 = -18 dBA/m is:

- 2. Measurement System Validation (See Figure 4-1)
 - a. The measurement system including the probe, pre-amplifier and acquisition system were validated as an entire system to ensure the reliability of test measurements.
 - b. ABM1 Validation

The magnetic field at the center of the Helmholtz coil is given by the equation (per C63.19 Annex D.10.1):

$$H_c = \frac{NI}{r\sqrt{1.25^3}} = \frac{N(\frac{V}{R})}{r\sqrt{1.25^3}}$$

Where H_c = magnetic field strength in amperes per meter N = number of turns per coil

For Helmholtz Coil SN: SBI 1052, N=20; r=0.13m; R=10.193Ω and using V=29mV:

$$H_c = \frac{20 \cdot (\frac{0.029}{10.193})}{0.13 \cdot \sqrt{1.25^3}} = 0.316 \, A/m \approx -10 \, dB (A/m)$$

Therefore a pure tone of 1kHz was applied into the coils such that 29mV was observed across the resistor. The voltmeter used for measurement was verified to be capable of measurements in the audio band range. This theoretically generates an expected field of $-10 \, \text{dB}(A/m)$ in the center of the Helmholtz coil which was used to validate the probe measurement at $-10 \, \text{dB}(A/m)$. This was verified to be within $\pm 0.5 \, \text{dB}$ of the $-10 \, \text{dB}(A/m)$ value (see Page 21).

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c. Frequency Response Validation

The frequency response through the Helmholtz Coil was verified to be within 0.5 dB relative to 1kHz, between 300 – 3000 Hz using the Normal signal as shown below:



Figure 4-6 Frequency Response Validation

d. ABM2 Measurement Validation

WD noise measurements are filtered with A-weighting and Half-Band Integration over a frequency range of 100Hz – 10kHz to process ABM2 measurements. Below is the verification of the system processing A-weighting and Half-Band integration between system input to output within 0.5 dB of the theoretical result:

Table 4-1
ABM2 Frequency Response Validation

	HBI, A -	HBI, A -	
f (Hz)	Measured	Theoretical	dB Var.
	(dB re 1kHz)	(dB re 1kHz)	
100	-16.180	-16.170	-0.010
125	-13.257	-13.250	-0.007
160	-10.347	-10.340	-0.007
200	-8.017	-8.010	-0.007
250	-5.925	-5.920	-0.005
315	-4.045	-4.040	-0.005
400	-2.405	-2.400	-0.005
500	-1.212	-1.210	-0.002
630	-0.349	-0.350	0.001
800	0.071	0.070	0.001
1000	0.000	0.000	0.000
1250	-0.503	-0.500	-0.003
1600	-1.513	-1.510	-0.003
2000	-2.778	-2.780	0.002
2500	-4.316	-4.320	0.004
3150	-6.166	-6.170	0.004
4000	-8.322	-8.330	0.008
5000	-10.573	-10.590	0.017
6300	-13.178	-13.200	0.022
8000	-16.241	-16.270	0.029
10000	-19.495	-19.520	0.025

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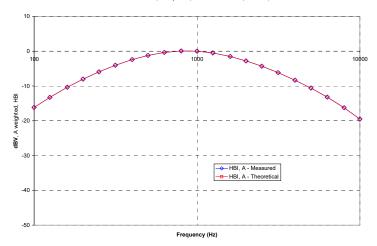
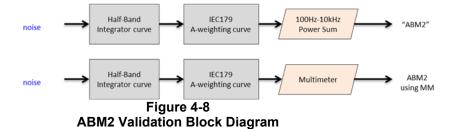


Figure 4-7
ABM2 Frequency Response Validation

The ABM2 result is a power sum from 100Hz to 10kHz with half-band integration and A-weighting. To verify the power sum measurement, a power sum over the full band was measured and verified to track with the source level (See Figure 4-8). Therefore the setup in this step was used to verify the power sum post-processing for ABM2 measurements. See below block diagram:



The power summed output results for a known input were compared to the multi-meter results to verify any deviation in the post-processing implemented with the power-sum.

Table 4-2
ABM2 Power Sum Validation

WN Input (dBV)	Power Sum (dBV)	Multimeter-Full (dBV)	Dev (dB)
-60	-60.36	-60.2	0.16
-50	-50.19	-50.13	0.06
-40	-40.14	-40.03	0.11
-30	-30.13	-30.01	0.12
-20	-20.12	-20	0.12
-10	-10.14	-10	0.14

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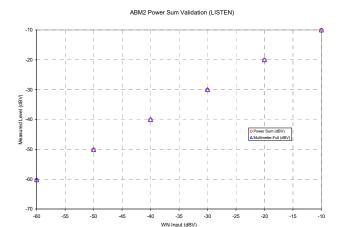
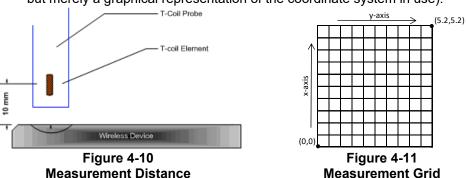


Figure 4-9 **ABM2 Power Sum Validation**

- 3. Measurement Test Setup
 - a. Fine scan above the WD (TEM)
 - i. A multitone signal was applied to the handset such that the phone acoustic output was stable within 1dB over the probe settling time and with the acoustic output level at the C63.19 specified levels (below). The measurement step size was in 2 mm increments at a distance of 10 mm between the surface of the wireless device as shown below (note that in Figure 4-11, the grid is not to scale but merely a graphical representation of the coordinate system in use):



- ii. After scanning, the planar field maximum point was determined. The position of the probe was moved to this location to setup the test using the SoundCheck system.
- iii. These steps were repeated for all T-coil orientations (axial and radial) per Figure 4-13 after a T-coil orientation was fully measured with the SoundCheck system.
- b. Speech Signal Setup to Base Station Simulator
 - i. C63.19 Table 7-1 states audio reference input levels for various technologies:

Standard	Technology	Input Level (dBm0)
TIA/EIA/IS-2000	CDMA	-18
J-STD-007	GSM (217)	-16
T1/T1P1/3GPP	UMTS (WCDMA)	-16
iDEN TM	TDMA (22 and 11 Hz)	-18

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- ii. See Section 5 for more information regarding audio level settings for Over-The-Top (OTT) Voice Over IP (VoIP) Testing.
- c. Real-Time Analyzer (RTA)
 - The Real-Time Analyzer was configured to analyze measurements using 1/3 Octave band weighted filtering.
- d. WD Radio Configuration Selection
 - The device was chosen to be tested in the worst-case ABM2 condition (NR configuration information can be found in Section 5.)
- 4. Signal Quality Data Analysis
 - a. Narrow-band Magnetic Intensity
 - i. The standard specifies a 1kHz 1/3 octave band minimum field intensity for a sine tone. The ABM1 measurements were evaluated at 1kHz with 1/3 octave band filtering over an averaged period of 10 seconds.
 - b. Frequency Response
 - i. The appropriate frequency response curve was measured to curves in Figure 3-1 or Figure 3-2 between 300 3000 Hz using digital linear averaging (limit lines chosen according to measurement found in step 4a). A linear average over 3x the length of the artificial voice signal (3x sampling) was performed. A 10 second delay was configured in the measurement process of the stimulus to ensure handset vocoder latency effects and echo cancellation devices (if any) were appropriately stabilized during measurements.
 - ii. The appropriate post-processing was applied according to the system processing chain illustrated in Figure 4-6. All R10 frequencies were plotted with respect to 0dB at 1kHz value and aligned with respect to the EIA-504 mask.
 - iii. The margin is represented by the closest measured data point on the curve to the EIA-504 limit lines, in dB.
 - c. Signal Quality Index
 - i. Ensuring the WD was at maximum RF power, maximum volume, backlight off, display on, maximum contrast setting, keypad lights on (when possible) with no audio signal through the vocoder, the WD was measured over at least 100 Hz 10,000 Hz, maximized over 5 seconds with a 50ms sample time for the ABM2 measurement (5 second time period is used in noise measurements under standards such as IEEE 269, etc.).
 - ii. After applying half-band integration and A-weighting to the result, a power sum was applied over each 1/3 octave bandwidth frequency for an ABM2 value.
 - This result was subtracted from the ABM1 result in step a, to obtain the Signal Quality.

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V. **Test Setup**

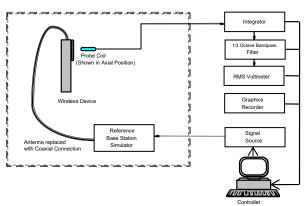


Figure 4-12 Audio Magnetic Field Test Setup

Environmental conditions such as temperature and relative humidity are monitored to ensure there are no impacts on system specifications. Proper voltage and power line frequency conditions are maintained with three phase power sources. Environmental noise and reflections are monitored through system checks.

Deviation from C63.19 Test Procedure VI.

Non-conducted RF connection due to inaccessible RF ports.

VII. Air Interface Technologies Tested

All air interfaces which support voice capabilities over a managed CMRS or pre-installed OTT VoIP applications were tested for T-coil unless otherwise noted. See Table 2-1 for more details regarding which modes were tested.

VIII. Wireless Device Channels and Frequencies

1. 5G (NR) Modes

The bandwidth combination from each probe orientation resulting in the worst-case SNNR was additionally tested using low, low-mid, mid-high, and high channels for that band and bandwidth combination. See Tables 6-2 and 6-3 for NR bandwidths and channels.

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IX. **Test Flow**

The flow diagram below was followed (From C63.19):

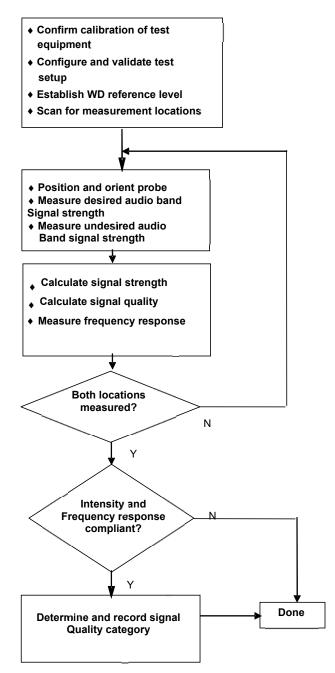


Figure 4-13 **C63.19 T-Coil Signal Test Process**

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5. OTT VOIP TEST SYSTEM AND DUT CONFIGURATION

I. Test System Setup for OTT VoIP T-Coil Testing

1. OTT VoIP Application

Google Duo is a pre-installed application on the DUT which allows for VoIP calls in a held-to-ear scenario. Duo uses the OPUS audio codec and supports a bitrate range of 6kb/s to 75kb/s. All air interfaces capable of a data connection were evaluated with Google Duo.

2. Equipment Setup

A CMW500 callbox and a CMX500 callbox were used together to perform NR OTT VoIP T-coil measurements. The Data Application Unit (DAU) of the CMW500 was connected to the internet and allowed for an IP data connection on the DUT. An auxiliary VoIP unit was used to initiate an OTT VoIP call to the DUT. The auxiliary VoIP unit allowed for the configuration and monitoring of the OTT VoIP codec bitrate during a call. Both high and low bitrate settings were evaluated in to determine the worst-case configuration.

3. Audio Level Settings

According to KDB 285076 D02, the average speech level of -20dBm0 shall be used for protocols not specifically listed in Table 7.1 of ANSI C63.19-2011 or the ANSI C63.19-2011 VoLTE interpretation². The auxiliary VoIP unit allowed for monitoring the signal input level to ensure that the settings for speech input and full scale levels resulted in the -20dBm0 speech input level to the DUT for the OTT VoIP call.

Note: The green highlighted text is approved by FCC under the TCB PAG Re-Use Policy 388624 D01 IV. D. for T-Coil Testing for WI-FI calling and Google Duo.

II. DUT Configuration for OTT VoIP T-Coil Testing

1. Codec Configuration

An investigation was performed for each applicable data mode to determine the audio codec configuration to be used for testing. The effects of codec configuration were found to be independent of radio configuration; therefore, only one radio configuration for each applicable data mode was used for these investigations. The 6kbps codec setting was used for the audio codec on the auxiliary VoIP unit for OTT VoIP T-Coil testing. Please refer to the Original Certification Test Report (T-Coil report S/N: 1M2104020031-24-R1.A3L) for full evaluation.

² FCC Office of Engineering and Technology KDB, "285076 D02 T-Coil Testing for CMRS IP v03," September 13, 2017

1 CC Office of Engineer	ing and recimology ND	D, 2000/0 DOZ 1-Coll resultg for Civilto II	voo, oeptember 15, 2	2017
FCC ID: A3LSMF926U	PCTEST* Provided to be post of the element	HAC (T-COIL) TEST REPORT	SAMSUNG	Approved by: Quality Manager
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2. Interim Procedure for evaluation OTT VoIP (NR)

The following procedure is used to evaluate OTT VoIP (NR) given equipment limitations.

- a. This procedure is applicable for OTT VoIP (NR) voice calls that use the same protocol, codec(s), and reference level as OTT VoIP (LTE) (i.e. -20dBm0).
- b. Establish the ABM1_{NR} value by using the ABM1_{LTE} magnetic intensity for an LTE call using a correlating LTE band through existing procedures and test equipment.
- c. Establish an $ABM2_{NR}$ value using factory test mode (FTM) to simulate a NR connection for the desired NR band and channel under test.
- d. The following information is documented in Section 9:
 - i. ABM2_{LTE} and ABM2_{NR} for respective tests.
 - ii. Calculate SNNR:
 - 1. ABM1 = ABM1_{LTE}
 - 2. $ABM2 = ABM2_{NR}$
 - 3. $SNNR_{NR} = [ABM1_{LTE} ABM2_{NR}] 3dB$
 - a. A 3dB margin is built in to ensure conservative results with this interim procedure.

The above is only applicable for OTT VoIP scenarios, this device does not support VoNR over IMS.

The manufacturer has confirmed the handset as designed is expected to exhibit similar audio intensity levels between an OTT VoIP call placed over a 4G LTE and a 5G Sub-6GHz data connection.

3. Radio Configuration for OTT VoIP (NR)

An investigation was performed to determine the waveform, modulation, and RB configuration to be used for testing. Due to equipment limitations, the procedure outlined in 5.II.2 was used to evaluate the SNNR for each radio configuration below. DFT-s-OFDM 256QAM, 1RB, 50%RB offset was determined to be the worst-case configuration for the handset and will be used for full testing in Section 6. Please refer to the Original Certification Test Report (T-Coil report S/N: 1M2104020031-24-R1.A3L) for full evaluation.

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6. T-COIL TEST SUMMARY

Table 6-1 Consolidated Tabled Results

			3		·		3		3		•		Margin from FCC Limit	C63.19-2011
C63.19 Section		8.3.2		8.3.1		8.3.4		(dB)	Rating					
		Axial	Radial	Axial	Radial	Axial	Radial							
NR TDD (OTT VoIP)	n48	NA	NA	PASS	PASS	PASS	PASS	-3.09	Т3					

I. Raw Handset Data

Table 6-2 Raw Data Results for NR n48

Mode	Orientation	Bandwidth	Channel	ABM1 _{LTE} [dB(A/m)]	ABM2 _{NR} [dB(A/m)]	ABM2 _{LTE} [dB(A/m)]	Ambient Noise [dB(A/m)]	Frequency Response Margin (dB)	S+N/N _{NR} (dB)	S+N/N _{NR} - 3 dB (dB)	FCC Limit (dB)	Margin from FCC Limit (dB)	C63.19-2011 Rating	Test Coordinates
		40MHz	645332	11.07	-25.95	-24.89			37.02	34.02	20.00	-14.02	T4	
		40MHz	643500	11.07	-25.44	-24.89			36.51	33.51	20.00	-13.51	T4	
		40MHz	641666	11.07	-24.14	-24.89	-24.89 -60.01 N/A -24.89 -24.89 -24.89 -24.89	35.21	32.21	20.00	-12.21	T4		
	Axial	40MHz	639834	11.07	-25.06	-24.89		-60.01 N/A	36.13	33.13	20.00	-13.13	T4	1.6, 1.8
		40MHz	638000	11.07	-25.11	-24.89			36.18	33.18	20.00	-13.18	T4	
		20MHz	641666	11.07	-25.24	-24.89			36.31	33.31	20.00	-13.31	T4	
NR n48		10MHz	641666	11.07	-25.17	-24.89			36.24	33.24	20.00	-13.24	T4	
NK 1140		40MHz	645332	3.51	-23.02	-25.02			26.53	23.53	20.00	-3.53	Т3	
		40MHz	643500	3.51	-23.12	-25.02			26.63	23.63	20.00	-3.63	Т3	
		40MHz	641666	3.51	-22.58	-25.02			26.09	23.09	20.00	-3.09	Т3	
	Radial	40MHz	639834	3.51	-23.00	-25.02	-58.62	N/A	26.51	23.51	20.00	-3.51	Т3	1.6, 2.6
		40MHz	638000	3.51	-22.97	-25.02			26.48	23.48	20.00	-3.48	T3	
		20MHz	641666	3.51	-22.75	-25.02			26.26	23.26	20.00	-3.26	Т3	
		10MHz	641666	3.51	-22.65	-25.02			26.16	23.16	20.00	-3.16	T3	

Table 6-3
Raw Data Results for LTE B48 (OTT VoIP – Additional Measurements for NR)

Mode	Orientation	Bandwidth	Channel	ABM1 _{LTE} [dB(A/m)]	ABM2 _{NR} [dB(A/m)]	ABM2 _{LTE} [dB(A/m)]	Ambient Noise [dB(A/m)]	Frequency Response Margin (dB)	S+N/N _{LTE} (dB)	S+N/N _{NR} - 3 dB (dB)	FCC Limit (dB)	Margin from FCC Limit (dB)	C63.19-2011 Rating	Test Coordinates
TE Band	Axial	20MHz	55990	11.07	.	-24.89	-60.01	NIA	35.96	N/A	20.00	-15.96	T4	1.6, 1.8
48	Radial	20MHz	55990	3.51	N/A	-25.02	-58.62	N/A	28.53	N/A	20.00	-8.53	Т3	1.6, 2.6

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II. Test Notes

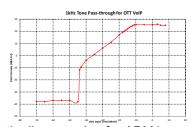
A. General

- 1. Phone Condition: Mute on; Backlight off; Max Volume; Max Contrast
- 2. 'Radial' orientation refers to radial transverse.
- 3. Hearing Aid Mode (Phone→Settings→Other call settings→Hearing aid compatibility) was set to ON for T-Coil testing
- 4. Bluetooth and WIFI were disabled while testing 5G modes.
- 5. The Margin from FCC limit column indicates a margin from the FCC limit for compliance (T3).

B. OTT VoIP

- 1. Vocoder Configuration: 6kbps
- 2. NR TDD Configuration
 - a. Power Configuration: TPC = "Max Power"
 - b. Radio Configuration: DFT-s-OFDM, 256QAM, 1RB, 50%RB offset
 - c. Due to equipment limitations, ABM1 measurements were not possible. Therefore, the procedure outlined in Section 5.II.2 was followed to obtain SNNR values. Additionally, Frequency Response measurements were not possible due to equipment limitations.
 - a. The worst-case band and bandwidth combination for each probe orientation is additionally tested on the low, low-mid, high-mid, and high channels for those combinations. NR n48 at 40MHz is the worst-case for both Axial and Radial probe orientations.

III. 1 kHz Vocoder Application Check



This model was verified to be within the linear region for ABM1 measurements at -20 dBm0 for OTT VoIP. This measurement was taken in the axial configuration above the maximum location.

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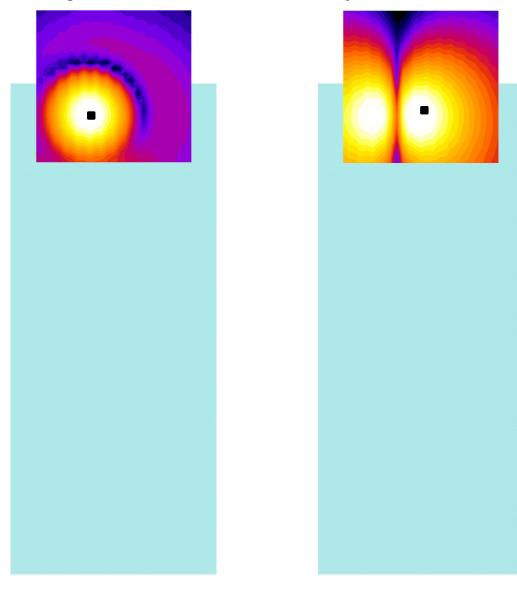
IV. T-Coil Validation Test Results

Table 6-4 Helmholtz Coil Validation Table of Results (5/3/2021)

Item	Target	Result	Verdict
Axial			
Magnetic Intensity, -10 dBA/m	-10 ± 0.5 dB	-9.930	PASS
Environmental Noise	< -58 dBA/m	-60.01	PASS
Frequency Response, from limits	> 0 dB	0.50	PASS
Radial			
Magnetic Intensity, -10 dBA/m	-10 ± 0.5 dB	-10.204	PASS
Environmental Noise	< -58 dBA/m	-58.62	PASS
Frequency Response, from limits	> 0 dB	0.70	PASS

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ABM1 Magnetic Field Distribution Scan Overlays ٧.



Axial Radial (Transverse)

Figure 6-1 T-Coil Scan Overlay Magnetic Field Distributions

Notes:

- 1. Final measurement locations are indicated by a cursor on the contour plots.
- 2. See Test Setup Photographs for actual WD overlay.

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MEASUREMENT UNCERTAINTY

Table 7-1 **Uncertainty Estimation Table**

Contribution	Data +/- %	Data +/- dB	Data Type	Probability distribution	Divisor	Standard uncertainty	Standard Uncertainty (dB)
ABM Noise	7.0%	0.29	Std. Dev.	Normal k=1	1.00	7.0%	
RF Reflections	4.7%	0.20	Specification	Rectangular	1.73	2.7%	
Reference Signal Level	12.2%	0.50	Specification	Rectangular	1.73	7.0%	
Positioning Accuracy	10.0%	0.41	Uncertainty	Rectangular	1.73	5.8%	
Probe Coil Sensitivity	12.2%	0.50	Specification	Rectangular	1.73	7.0%	
Probe Linearity	2.4%	0.10	Std. Dev.	Normal k=1	1.00	2.4%	
Cable Loss	2.8%	0.12	Specification	Rectangular	1.73	1.6%	
Frequency Analyzer	5.0%	0.21	Specification	Rectangular	1.73	2.9%	
System Repeatability	5.0%	0.21	Std. Dev.	Normal k=1	1.00	5.0%	
WD Repeatability	9.0%	0.37	Std. Dev.	Normal k=1	1.00	9.0%	
Positioner Accuracy	1.0%	0.04	Specification	Rectangular	1.73	0.6%	
Combined standard uncertainty		17.7%	0.71				
Expanded uncertainty (k=2),	Expanded uncertainty (k=2), 95% confidence level						

Notes:

- Test equipments are calibrated according to techniques outlined in NIS81, NIS3003 and NIST Tech Note 1297.
- All equipments have traceability according to NIST. Measurement Uncertainties are defined in further detail in NIS 81 and NIST Tech Note 1297 and UKAS M3003.

Measurement uncertainty reflects the quality and accuracy of a measured result as compared to the true value. Such statements are generally required when stating results of measurements so that it is clear to the intended audience that the results may differ when reproduced by different facilities. Measurement results vary due to the measurement uncertainty of the instrumentation, measurement technique, and test engineer. Most uncertainties are calculated using the tolerances of the instrumentation used in the measurement, the measurement setup variability, and the technique used in performing the test. While not generally included, the variability of the equipment under test also figures into the overall measurement uncertainty. Another component of the overall uncertainty is based on the variability of repeated measurements (so-called Type A uncertainty). This may mean that the Hearing Aid compatibility tests may have to be repeated by taking down the test setup and resetting it up so that there are a statistically significant number of repeat measurements to identify the measurement uncertainty. By combining the repeat measurement results with that of the instrumentation chain using the technique contained in NIS 81 and NIS 3003, the overall measurement uncertainty was estimated.

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8. EQUIPMENT LIST

Table 8-1 Equipment List

	Equipment List								
Manufacturer	Model			Cal Interval	Cal Due	Serial Number			
Dell	Latitude E6540	SoundCheck Acoustic Analyzer Laptop	9/29/2020	Biennial	9/29/2022	2655082910			
Listen	SoundConnect	Microphone Power Supply	9/24/2020	Biennial	9/24/2022	0899-PS150			
RME	Fireface UC	Soundcheck Acoustic Analyzer External Audio Interface	9/29/2020	Biennial	9/29/2022	23792992			
Rohde & Schwarz	CMW500	Wideband Radio Communication Tester	9/24/2021	Annual	9/24/2022	167286			
Rohde & Schwarz	CMX500	5G Radio Communication Tester	N/A	N/A	N/A	100298			
Seekonk	NC-100	Torque Wrench (8" lb)	8/4/2020	Biennial	8/4/2022	21053			
TEM	Axial T-Coil Probe	Axial T-Coil Probe	9/23/2020	Biennial	9/23/2022	TEM-1123			
TEM	Radial T-Coil Probe	Radial T-Coil Probe	9/23/2020	Biennial	9/23/2022	TEM-1129			
TEM		HAC Positioner	N/A	N/A	N/A	N/A			
TEM		HAC System Controller with Software	N/A	N/A	N/A	N/A			
TEM	Helmholtz Coil	Helmholtz Coil	9/23/2020	Biennial	9/23/2022	SBI 1052			
YellowTec	YT4211	USB Audio Interface	N/A	N/A	N/A	20000365			
Control Company	4040	Therm./ Clock/ Humidity Monitor	3/12/2021	Biennial	3/12/2023	210202053			
Netgear	XS708E	Ethernet Switch	N/A	N/A	N/A	4FU3875C001A8			

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9. TEST DATA

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PCTEST Hearing-Aid Compatibility Facility

DUT: HH Coil - SN: SBI 1052

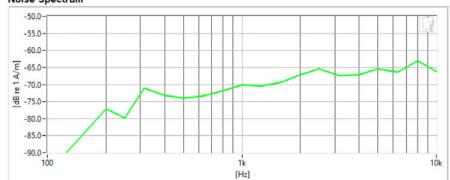
Type: HH Coil Serial: SBI 1052

Measurement Standard: ANSI C63.19-2011

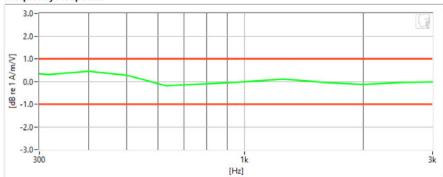
Equipment:

- Probe: Axial T-Coil Probe SN: TEM-1123; Calibrated: 9/23/2020
- Helmholtz Coil SN: SBI 1052; Calibrated: 9/23/2020

Noise Spectrum



Frequency Response



Results

Verification 1kHz Intensity	-9.93 dE	•	Max/Min	-9.5/-10.5
Verification ABM2	-60.01 dE	•	Maximum	-58.0
Frequency Response Margin	500m dE	•	Tolerance curves	Aligned Data

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DUT: HH Coil - SN: SBI 1052

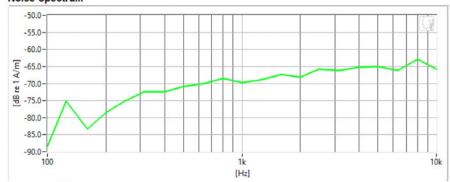
Type: HH Coil Serial: SBI 1052

Measurement Standard: ANSI C63.19-2011

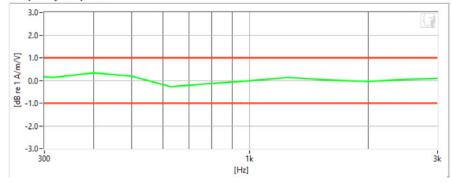
Equipment:

- Probe: Radial T-Coil Probe SN: TEM-1129; Calibrated: 9/23/2020
- Helmholtz Coil SN: SBI 1052; Calibrated: 9/23/2020

Noise Spectrum



Frequency Response



Results

Verification 1kHz Intensity	-10.204	dB	\checkmark	Max/Min	-9.5/-10.5
Verification ABM2	-58.62	dB	•	Maximum	-58.0
Frequency Response Margin	700m	dB	•	Tolerance curves	Aligned Data

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DUT: A3LSMF926U Type: Portable Handset Serial: 2037M

Measurement Standard: ANSI C63.19-2011

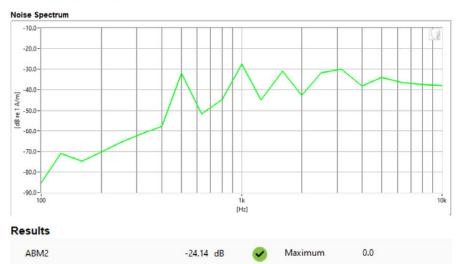
Equipment:

Probe: Axial T-Coil Probe – SN: TEM-1123; Calibrated: 9/23/2020

Test Configuration:

· VolP Application: Google Duo

Mode: NR TDD n48
Bandwidth: 40MHz
Channel: 641666



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DUT: A3LSMF926U Type: Portable Handset Serial: 2037M

Measurement Standard: ANSI C63.19-2011

Equipment:

Probe: Radial T-Coil Probe – SN: TEM-1129; Calibrated: 9/23/2020

Test Configuration:

VolP Application: Google Duo
 Mode: NR TDD n48

Mode: NR 1DD n48
Bandwidth: 40MHz
Channel: 641666



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10. CALIBRATION CERTIFICATES

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Certificate of Conformance

for

AXIAL T COIL PROBE

Manufactured by: TEM CONSULTING Model No: AXIAL T COIL PROBE

Serial No: TEM-1123 Calibration Recall No: 31288

Submitted By:

Customer: ANDREW HARWELL

Company: PCTEST ENGINEERING LAB Address: 6660-B DOBBIN ROAD

COLUMBIA MD 21045

The subject instrument was calibrated to the indicated specification using standards traceable to the SI through the National Institute of Standards and Technology or to accepted values of natural physical constants. This document certifies that the instrument met the following specification upon its return to the submitter.

West Caldwell Calibration Laboratories Procedure No. AX

AXIALT C TEM C V

Upon receipt for Calibration, the instrument was found to be:

10/13/2020

Within (X)

tolerance of the indicated specification. See attached Report of Calibration. The information supplied relates to the calibrated item listed above and statment of conformance for ALL given specifications and standards fall under the decision rule: A=(L-(U95)), where A is acceptance limit, L is manufacturer specifications and U95 is confidence level of 95% at k=2. This includes but not limited to:1. Measured value does not meet manufacturer's tolerance, 2.Manufacturer's tolerance is too small compared to calibration and measurment capability uncertainties, 3. Test uncertainty ratio does not meet the 4:1 ratio due to test instrumentation limitations. The decision rule has been communicated and approved by customer during contract

West Caldwell Calibration Laboratories' calibration control system meets the following requirements, ISO 10012-1 MIL STD 45662A, ANSI/NCSL Z540-1, IEC Guide 25, ISO 9001;2015, and ISO 17025

Note: With this Certificate, Report of Calibration is included.

Approved by:

Calibration Date: 23-Sep-20

James Zhu

Certificate No: 31288 -2

Quality Manager ISO/IEC 17025:2017

ISO/IEC 17025:2

QA Doc. #1051 Rev. 3.0 5/29/20 Certificate Page 1 of 1

ACCREDITED

Calibration uncompromised calibration Laboratories, Inc.

Calibration Lab. Cert. # 1533.01

1575 State Route 96, Victor, NY 14564, U.S.A.

FCC ID: A3LSMF926U

PCTEST
HAC (T-COIL) TEST REPORT

Approved by:
Quality Manager
Filename:

DUT Type:

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1575 State Route 96, Victor NY 14564

Calibration results:



REPORT OF CALIBRATION

TEM Consulting LP Axial T Coil Probe Company: PCTest Engineering Lab

the number of turns on each coil;

the radius of each coil, in meters;

Helmholtz Coil Constant;

Probe Sensitivity at

Probe resistance

Helmholtz Coil magnetic field;

the current in the coils, in amperes.;

Model No.: Axial T Coil Probe

Serial No.: TEM-1123 I. D. No.: XXXX

°C

% RH

kPa

Before & after data same: ... X...

Ambient Temperature:

Ambient Humidity:

Ambient Pressure:

10 No. 0.204 m Laboratory Environment:

0.08 Α 7.04 A/m/V

1000

0.972

898

5.71 A/m

Hz. dBV/A/m -60.24

Calibration Due: mV/A/m Ohms

31288 -2

20.7

42.1

99.094

Report Number: Control Number: 31288

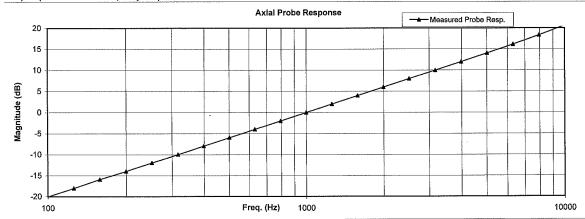
Calibration Date: 23-Sep-2020

The above listed instrument meets or exceeds the tested manufacturer's specifications.

684.07/O-000001126-20 This Calibration is traceable through NIST test numbers: The expanded uncertainty of calibration: 0.30dB at 95% confidence level with a coverage factor of k=2.

Probe Sensitivity measured with Helmholtz Coil Helmholtz Coil;

Graph represents Probes Frequency Response.



The above listed instrument was checked using calibration procedure documented in West Caldwell

Calibration Laboratories Inc. procedure :

Rev. 7.0 Jan. 24, 2014 Doc. # 1038 HCATEMC

Calibration was performed by West Caldwell Calibration Laboratories Inc. under Operating Procedures

intended to implement the requirements of ISO10012-1, IEC Guide 25, ANSI/NCSL Z540-1, (MIL-STD-45662A) and ISO 9001:2015) ISO 17025

Cal. Date: 23-Sep-2020

Measurements performed by:

James Zhu

Calibrated on WCCL system type 9700 This document shall not be reproduced, except in full, without the written approval from West Caldwell Cal. Labs. Inc.

Rev. 7.0 Jan. 24, 2014 Doc. # 1038 HCATEMC

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HCATEMC_TEM-1123_Sep-23-2020

West Caldwell Calibration Laboratories Inc.

1575 State Route 96, Victor NY 14564 Tel. (585) 586-3900 FAX (585) 586-4327

Calibration Data Record

for Model No.: Axial T Coil Probe

Serial No.: TEM-1123

TEM Consulting LP Axial T Coil Probe Company: PCTest Engineering Lab

Test	Function	Tolerance		Measured values		
				Before	Out	Remarks
1.0	Probe Sensitivity at	1000 Hz.	dBV/A/m	-60.24		
			dB			
2.0	Probe Level Linearity		6	6.03		
		Ref. (0 dB)	0	0.00		
			-6	-6.03		
			-12	-12.05		
	The state of the s		Hz			
3.0	Probe Frequency Response		100	-20.0		
			126	-18.0		
			158	-15.9		
			200	-14.0		
	•		251	-12.0		
			316	-10.0		
			398	-8.0		
			501	-6.0		
			631	-4.0		
			794	-2.0		
		Ref. (0 dB)	1000	0.0		
			1259	2.0		
			1585	4.0		
			1995	6.0		
			2512	8.0		
			3162	10.0		
			3981	12.0		
			5012	14.0		1
			6310	16.1		
			7943	18.3		
			10000	20.7		
				l		.l

Instruments u	sed for calibration:		Date of Cal.	Traceablity No.	Due Date
HP	34401A	S/N US360641	2-Jul-2020	,610119	2-Jul-2021
HP	34401A	S/N US361024	2-Jul-2020	,610119	2-Jul-2021
HP	33120A	S/N US360437	2-Jul-2020	.610119	2-Jul-2021
B&K	2133	S/N 1583254	1-Jul-2020	684.07/O-0000001126-20	1-Jul-2021

Cal. Date: 23-Sep-2020

Calibrated on WCCL system type 9700

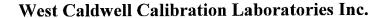
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Tested by: James Zhu

Rev. 7.0 Jan. 24, 2014 Doc. # 1038 HCATEMC

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Certificate of Conformance

for

RADIAL T COIL PROBE

Manufactured by:

TEM CONSULTING

Model No:

RADIAL T COIL PROBE

Serial No:

TEM-1129 31288

Calibration Recall No:

Submitted By:

Customer:

ANDREW HARWELL

Company:

PCTEST ENGINEERING LAB

Address:

6660-B DOBBIN ROAD

COLUMBIA

MD 21045

The subject instrument was calibrated to the indicated specification using standards traceable to the SI through the National Institute of Standards and Technology or to accepted values of natural physical constants. This document certifies that the instrument met the following specification upon its return to the submitter.

West Caldwell Calibration Laboratories Procedure No.

RADIAL T TEM C

Upon receipt for Calibration, the instrument was found to be:

10/13/2020

Within (X)

tolerance of the indicated specification. See attached Report of Calibration.

The information supplied relates to the calibrated item listed above and statment of conformance for ALL given specifications and standards fall under the decision rule: A=(L-(U95)), where A is acceptance limit, L is manufacturer specifications and U95 is confidence level of 95% at k=2. This includes but not limited to:1. Measured value does not meet manufacturer's tolerance, 2.Manufacturer's tolerance is too small compared to calibration and measurment capability uncertainties, 3. Test uncertainty ratio does not meet the 4:1 ratio due to test instrumentation limitations. The decision rule has been communicated and approved by customer during contract

West Caldwell Calibration Laboratories' calibration control system meets the following requirements, ISO 10012-1 MIL STD 45662A, ANSI/NCSL Z540-1, IEC Guide 25, ISO 9001:2015, and ISO 17025

Note: With this Certificate, Report of Calibration is included.

Approved by:

Calibration Date:

23-Sep-20

James Zhu

Certificate No:

31288 - 1

West Caldwell

Quality Manager ISO/IEC 17025:2017

QA Doc. #1051 Rev. 3.0 5/29/20

Certificate Page 1 of 1

Calibration uncompromised calibration Laboratories. Inc.

1575 State Route 96, Victor, NY 14564, U.S.A.

Calibration Lab. Cert. # 1533.01

FCC ID: A3LSMF926U

PCTEST
HAC (T-COIL) TEST REPORT

Quality Manager

Filename:

1M2112280170-04.A3L

5/3/2021

Portable Handset

Approved by:
Quality Manager

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REV 3.5.M



ACCREDITED
Calibration Lab. Cert. # 1533.01

ISO/IEC 17025: 2017

1575 State Route 96, Victor NY 14564

REPORT OF CALIBRATION

for

TEM Consulting LP Radial T Coil Probe Company: PCTest Engineering Lab

Model No.: Radial T Coil Probe

Serial No.: TEM-1129

I. D. No.: XXXX

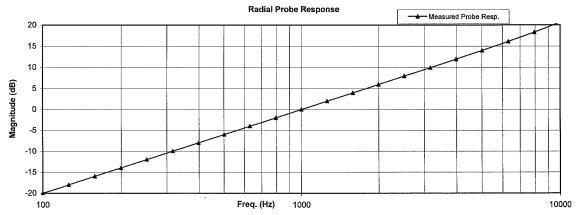
Calibration results: Probe Sensitivity measured with Helmholtz Coil Helmholtz Coil; Before & after data same: ...X... the number of turns on each coil: 10 No. the radius of each coil, in meters; 0.204 m Laboratory Environment: ٥c the current in the coils, in amperes.; 0.08 Α Ambient Temperature: 20.7 Helmholtz Coil Constant; 7.04 A/m/V Ambient Humidity: 42.1 % RH Helmholtz Coil magnetic field; 5.70 A/m Ambient Pressure: 99.094 Calibration Date: 23-Sep-2020 Probe Sensitivity at 1000 Re-calibration Due: Hz. dBV/A/m 31288 -1 was -60.37 Report Number: 31288 0.959 mV/A/m Control Number: Probe resistance 897 Ohms

The above listed instrument meets or exceeds the tested manufacturer's specifications. This Calibration is traceable through NIST test numbers: 684.07/O-0000001126-20

This Calibration is traceable through No Flest Humbers. 004.07/O-000001120-

The expanded uncertainty of calibration: 0.30dB at 95% confidence level with a coverage factor of k=2.

Graph represents Probes Frequency Response.



The above listed instrument was checked using calibration procedure documented in West Caldwell

Calibration Laboratories Inc. procedure :

Rev. 7.0 Jan. 24, 2014 Doc. # 1038 HCRTEMC

Calibration was performed by West Caldwell Calibration Laboratories Inc. under Operating Procedures

intended to implement the requirements of ISO10012-1, IEC Guide 25, ANSI/NCSL Z540-1, (MIL-STD-45662A) and ISO 9001:2015, ISO 17925

Cal. Date: 23-Sep-2020

IVIC

Calibrated on WCCL system type 9700

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HCRTEMC_TEM-1129_Sep-23-2020

West Caldwell Calibration Laboratories Inc.

1575 State Route 96, Victor NY 14564 Tel. (585) 586-3900 FAX (585) 586-4327

Calibration Data Record

TEM Consulting LP Radial T Coil Probe Company: PCTest Engineering Lab

for Model No.: Radial T Coil Probe

Serial No.: TEM-1129

Test	Function	Tolerance		Measured values		
				Before	Out	Remarks
1.0	Probe Sensitivity at	1000 Hz.	dBV/A/m	-60.37		
			dB			· · · · · · · · · · · · · · · · · · ·
2.0	Probe Level Linearity		6	6.04		
	•	Ref. (0 dB)	0	0.00		
		, ,	-6	-6.03		
			-12	-12.05		
			Hz			
3.0	Probe Frequency Response		100	-20.0		
			126	-18.0		
			158	-16.0		
	•		200	-14.0		
			251	-12.0		
			316	-10.0		
			398	-8.0		
			501	-6.0		1
			631	-4.0		1
			794	-2.0		
		Ref. (0 dB)	1000	0.0		
			1259	2.0		
			1585	4.0		
			1995	6.0		
			2512	8.0		
			3162	10.0		
			3981	12.0		
			5012	14.0		
			6310	16.1		
			7943	18.3		
			10000	20.7		

Instrument	ts used for calibration:		Date of Cal.	Traceability No.	Due Date
HP	34401A	S/N US360641	2-Jul-2020	,610119	2-Jul-2021
HP	34401A	S/N US361024	2-Jul-2020	.610119	2-Jul-2021
HP	33120A	S/N US360437	2-Jul-2020	.610119	2-Jul-2021
B&K	2133	S/N 1583254	1-Jul-2020	684.07/O-0000001126-20	1-Jul-2021

Cal. Date: 23-Sep-2020

Calibrated on WCCL system type 9700

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Tested by: James Zhu

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FCC ID: A3LSMF926U	PCTEST* Proud to be port of @ observed	HAC (T-COIL) TEST REPORT		Approved by: Quality Manager
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11. CONCLUSION

The measurements indicate that NR n48 for the wireless communications device complies with the HAC limits specified in accordance with the ANSI C63.19 Standard and FCC WT Docket No. 01-309 RM-8658. Precise laboratory measures were taken to assure repeatability of the tests. The tested device complies with the requirements in respect to all parameters specific to the test. The test results and statements relate only to the item(s) tested.

The measurement system and techniques presented in this evaluation are proposed in the ANSI standard as a means of best approximating wireless device compatibility with a hearing-aid. The literature is under continual re-construction.

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FCC ID: A3LSMF926U	PCTEST: Proud to be port of ® element	HAC (T-COIL) TEST REPORT		Approved by: Quality Manager
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FCC ID: A3LSMF926U	PCTEST: Proud to be port of ® element	HAC (T-COIL) TEST REPORT		Approved by: Quality Manager
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